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SEP 02 2003
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List of Patent and Publications
Cited by Applicant
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U.S. Department of Commerce
Patent and Trademark Office

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| Docket No. MAX-0010 | Application No. 10/637,208 |
| Applicant Andrew W. Batchelor, et al. | |
| Filing Date August 8, 2003 | Group Not yet known |
| Confirmation No. Not yet known | |

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EXAMINER *Willie C Daenb* DATE CONSIDERED *10-4-04*


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EXAMINER William C. Dorey DATE CONSIDERED 10-4-04